

Form PTO 1449  
(Modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

253993US2PCT

SERIAL NO. 500717  
New U.S. PCT Application  
Based on PCT/JP02/00233

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Akira TAKAHASHI

FILING DATE

Herewith

GROUP

2816

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>M</i>	AO	4-113718	04/15/92	JP(with English abstract)	<i>/</i>	NO
	AP	2000-148281	05/26/00	JP(with English abstract)	<i>/</i>	NO
	AQ	2001-251182	09/14/01	JP(with English abstract)	<i>/</i>	NO
	AR	10-290158	10/27/98	JP(with English abstract)	<i>/</i>	NO
	AS	11-298460	10/29/99	JP(with English abstract)	<i>/</i>	NO
	AT	8-37459	02/06/96	JP(with English abstract)	<i>/</i>	NO
	AU	2001-77690	03/23/01	JP(with English abstract)	<i>/</i>	NO
	AV	2000-31952	01/28/00	JP(with English abstract)	<i>/</i>	NO
	AW	8-18447	01/19/96	JP(with English abstract)	<i>/</i>	NO
<i>V</i>	AX	6-232739	08/19/94	JP(with English abstract)	<i>/</i>	N

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

9/9/05

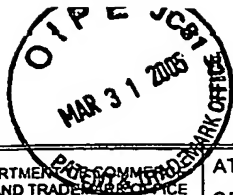
\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Best Available Copy



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 253993US2PCT		SERIAL NO. 10/500,717	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Akira TAKAHASHI			
				FILING DATE July 6, 2004		GROUP 28/6	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	4-113718	04/15/92	JP(with English abstract, equivalent of US 5122677)	—	NO	
	AP	2000-148281	05/26/00	JP(with English abstract)	—	NO	
	AQ	2001-251182	09/14/01	JP(with English abstract)	—	NO	
	AR	10-290158	10/27/98	JP(with English abstract)	—	NO	
	AS						
	AT						
	AU						
	AV						
	AW						
	AX						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				Date Considered			
[Signature]				9/9/05			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Best Available Copy

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
253993US2PCTSERIAL NO.  
10/500,717

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Akira TAKAHASHIFILING DATE  
July 6, 2004GROUP  
2816

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>Dr</i>	AA	2002/0001359 A1	01/03/2002	Simon SKIERSZKAN, et al.	/	/	/
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW		
	AX		
	AY		
	AZ		

☐ Additional References sheet(s) attached

Examiner

Date Considered

9/9/05

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.